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# CHIP MONOLITHIC CERAMIC CAPACITOR FOR AUTOMOTIVE GCM32ER71A226ME12\_ (1210, X7R, 22uF, 10Vdc)

\_: packaging code Reference Sheet

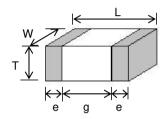
### 1.Scope

This product specification is applied to Chip Monolithic Ceramic Capacitor used for Automotive Electronic equipment.

#### 2.MURATA Part NO. System

(Ex.)	GCM	32	E	R7	1A	226	М	E12	L
		(1)L/W Dimensions	(2)T Dimensions	(3)Temperature Characteristics	(4)DC Rated Voltage	(5)Nominal Capacitance	(6)Capacitance Tolerance	(7)Murata's Control Code	(8)Packaging Code

#### 3. Type & Dimensions



(Unit:mm)

(1)-1 L	(1)-2 W	(2) T	е	g
3.2±0.3	2.5±0.2	2.5±0.2	0.3 min.	1.0 min.

#### 4.Rated value

(3) Temperature (Public STD C	(4) DC Rated	(5) Nominal	(6) Capacitance	Specifications and Test Methods	
Temp. coeff or Cap. Change	Temp. Range (Ref.Temp.)	Voltage	Capacitance	Tolerance	(Operationg Temp. Range)
-15 to 15 %	-55 to 125 °C (25 °C)	10 Vdc	22 uF	±20 %	-55 to 125 °C

#### 5.Package

mark	(8) Packaging	Packaging Unit
L	φ180mm Reel EMBOSSED W8P4	1000 pcs./Reel
K	φ330mm Reel EMBOSSED W8P4	4000 pcs./Reel

Product specifications in this catalog are as of Jan.26,2013,and are subject to change or obsolescence without notice. Please consult the approval sheet before ordering.

Please read rating and !Cautions first.

## ■ AEC-Q200 Murata Standard Specification and Test Methods

No	No AEC-Q200 Test Item		Specification.	AEC-Q200 Test Method					
1	Pre-and Post-Stress Electrical Test			-					
2	High Temperature Exposure (Storage)		-			Set the capacitor for 1000±12 hours at 150±3°C. Set for 24±2 hours at room temperature, then measure.			
		Appearance	No marking defects						
		Capacitance Change	R7: Within ±10%						
		Dissipation	R7: 0.2max						
		Factor							
		Insulation Resistance	50Ω ·F min.						
2	Tomporatura Cyalina			F: 11					
3	Temperature Cycling		The measured and observed characteristics should satisfy the						ner and under
			specifications in the following table.	+					test according to
		Appearance	No marking defects	7				owing table. S	et for 24±2 hours at
		Capacitance	R7: Within ±7.5%	room	tempera	ture, then me	asure		
		Change	R7: 0.2max	+	Step	1	2	3	4
		Dissipation Factor	N7. U.ZIIIdX		Temp.	-55+0/-3	Room Temp.	125+3/-0	Room Temp.
		Insulation	50Ω · F min.	<u> </u>	Time (min.)	15±3	1	15±3	1
	Resistance			Initial measurement for high dielectric constant type Perform a heat treatment at 150+0/-10 °C for one hour and then set for 24±2 hours at room temperature. Perform the initial measurement.		and then set			
4	Destructive	I.	No defects or abnormalities	Per E	IA-469				
	Phisical Analysis								
5	Moisture Resistance		The measured and observed characteristics should satisfy the	Apply the 24-hour heat (25 to 65°C) and humidity (80 to 98%) treatment shown below, 10 consecutive times.			0 98%)		
			specifications in the following table.	4					
		Appearance	No marking defects	Set io	or 24±2	nours at room	•	e, then measur	
		Capacitance	R7: Within ±10%		erature	Humidity	Humidity 80∼98% Hu	Humidit µmidity 80∼98%	y Humidity
		Change	D7.00	(°C		90~98%		)~98%	90~98%
		Dissipation Factor Insulation	R7: 0.2max 50Ω · F min.	65 60 55 50 45 40 35 30					
		Resistance	302 · F IIIII.	20 15 10 5 0 -5	Initia		0ne cycle 8 9 10 11 12	24hours 13 14 15 16 17 18 Hours	19 20 21 22 23 24
				Perfo	Measurement after test for high dielectric constant type Perform a heat treatment at 150+0/–10°C for one hour and then let sit for 24±2 hours at room temperature, then measure.				
6	Appearance		The measured and observed characteristics should satisfy the					dc (add 6.8kΩ	
۱			specifications in the following table.			•		000±12 hours.	
			No marking defects	4				temprature, th	nen measure.
			R7: Within ±10%	4		scharge curre			
			R7: 0.2 max	• Me	asuremei	nt after test fo	r high dielec	tric constant ty	rpe
		Factor		Perfo	orm a hea	at treatment at	150+0/–10°	C for one hour then measure.	and then let
		Insulation	5Ω ·F min.	Ť					
		Resistance							

AEC-Q200 Test Item		Specification.	AEC-Q200 Test Method		
Operational Lif	fe Appearance	The measured and observed characteristics should satisfy the specifications in the following table.  No marking defects	Apply 150% of the rated voltage for 1000±12 hours at 125±3°C.  Set for 24±2 hours at room temperature, then measure.  The charge/discharge current is less than 50mA.		
	Capacitance Change	R7: Within ±12.5%	Initial measurement for high dielectric constant type		
	Dissipation Factor	R7: 0.2max	Perform a heat treatment at 150+0/-10°C for one hour and then set for 24±2 hours at room temperature.  Perform the initial measurement.		
	Insulation Resistance	5Ω •F min.	Measurement after test for high dielectric constant type  Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature, then measure.		
External Visua	ıl	No defects or abnormalities	Visual inspection		
Phisical Dimen	nsion	Within the specified dimensions	Using calipers		
0 Resistance to	Appearance	No marking defects	Per MIL-STD-202 Method 215		
Solvents	Capacitance	Within the specified tolerance	Solvent 1: 1 part (by volume) of isopropyl alcohol		
	Change		3 parts (by volume) of mineral spirits		
	Dissipation	R7: 0.1max	Solvent 2 : Terpene defluxer		
	Factor		Solvent 3: 42 parts (by volume) of water		
			1part (by volume) of propylene glycol monomethylether		
			1 part (by volume) of monoethanolomine		
	Insulation Resistance	50Ω • Fmin.			
1 Mechanical	Appearance	No marking defects	Three shocks in each direction should be applied along 3 mutually		
Shock	Capacitance	Within the specified tolerance	perpendicular axes of the test specimen (18 shocks).		
	Change		The specified test pulse should be Half-sine and should have a		
	Dissipation Factor	R7: 0.1max	duration :0.5ms, peak value:1500g and velocity change: 4.7m/s.		
	Insulation Resistance	50Ω ·F min.			
2 Vibration	Appearance	No defects or abnormalities	Solder the capacitor to the test jig (glass epoxy board) in the same		
	Capacitance	Within the specified tolerance	manner and under the same conditions as (19). The capacitor		
	Change		should be subjected to a simple harmonic motion having a total		
	Dissipation Factor	R7: 0.1max	amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 2000Hz. The frequency range, from 10 to 2000Hz and return to 10Hz, should be traversed in approximately 20 minutes. This motion should be applied for 12		
	Insulation Resistance	50Ω ·F min.	items in each 3 mutually perpendicular directions (total of 36 times).		
Resistance to		The measured and observed characteristics should satisfy the	Immerse the capacitor in a eutectic solder solution at 260±5°C for		
Soldering Heat	t Appearance	specifications in the following table.  No marking defects	10±1 seconds. Set at room temperature for 24±2 hours, then measure.		
	Capacitance	Within the specified tolerance			
	Change Dissipation Factor	R7: 0.1max	<ul> <li>Initial measurement for high dielectric constant type</li> <li>Perform a heat treatment at 150+0/-10 °C for one hour and then set for 24±2 hours at room temperature.</li> <li>Perform the initial measurement.</li> </ul>		
1					

### ■ AEC-Q200 Murata Standard Specification and Test Methods

No	AEC-Q200 Test Item  Thermal Shock  Appearance Capacitance Change		Specification.	AEC-Q200 Test Method			
14			The measured and observed characteristics shall satisfy the specifications in the following table.  No marking defects  R7: Within ±10.0%	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (19). Perform the 300 cycles according to the two heat treatments listed in the following table(Maximum transfer time is 20 seconds). Set for 24±2 hours at room temperature, then measure			
		Dissipation	R7: 0.1max				
		Factor F7. U.Tillax		Step 1 2 Temp.(°C) -55+0/-3 125+3/-0			
		Insulation Resistance	50Ω •F min.	Time (min.) 15±3 15±3			
				<ul> <li>Initial measurement for high dielectric constant type</li> <li>Perform a heat treatment at 150+0/-10 °C for one hour and then set for 24±2 hours at room temperature.</li> <li>Perform the initial measurement.</li> </ul>			
15	ESD	Appearance	No marking defects	Per AEC-Q200-002			
		Capacitance Change	Within the specified tolerance				
		Dissipation Factor	R7: 0.1max				
		Insulation Resistance	50Ω •F min.				
16	Solderability	95% of the terminations is to be soldered evenly and continuously.		(a) Preheat at 155°C for 4 hours. After preheating, immerse the capacitor in a solution of ethanol(JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight propotion). Immerse in eutectic solder solution for 5+0/-0.5 seconds at 235±5°C.			
				(b) Should be placed into steam aging for 8 hours±15 minutes. After preheating, immerse the capacitor in a solution of ethanol(JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight propotion). Immerse in eutectic solder solution for 5+0/-0.5 seconds at 235±5°C.			
				(c) Should be placed into steam aging for 8 hours±15 minutes.  After preheating, immerse the capacitor in a solution of ethanol(JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight propotion). Immerse in eutectic solder solution for 120±5 seconds at 260±5°C.			
7	Electrical	Appearance	No defects or abnormalities	Visual inspection.			
(	Chatacteri- zation	Capacitance Change	Within the specified tolerance	The capacitance/Q/D.F. should be measured at 25°C at the frequency and voltage shown in the table.			
		Dissipation Factor	R7 :0.1max	$\begin{array}{ c c c c c c }\hline Char. & R7 & R7 & R7 \\ 6.3V \text{ max.} & 10V \text{ min.} & (10\mu\text{F} < \text{C}) \\ \hline Item & C \leq 10\mu\text{F}) & (C \leq 10\mu\text{F}) & 1\pm 0.1\text{kHz} & 120\pm 24\text{Hz} \\ \hline Voltage & 0.5\pm 0.1V\text{rms} & 1\pm 0.2V\text{rms} & 0.5\pm 0.1V\text{rms} \\\hline \end{array}$			
		Insulation Resistance 25 °C Insulation	$50\Omega \cdot F$ min. $5\Omega \cdot F$ min.	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and 125°C within 1 minute of charging.			
		Resistance 125°C 150°C	V · · · · · · · · · · · · · · · · · ·				
		Dielectric Strength	No failure	No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/ discharge current is less than 50mA.			

# ■ AEC-Q200 Murata Standard Specification and Test Methods

No	AEC-Q200	Test Item	Specification.	AEC-Q200 Test Method			
18				Solder the capacitor on the test jig (glass epoxy board) shown in Fig1 using a eutectic solder. Then apply a force in the direction shown in Fig 2 for 5±1sec. The soldering should be done by the			
		Capacitance Change	R7: Within ±10.0%	reflow method and should be conducted with care so that the コンデ・ンザ soldering is uniform and free of defects such as heat shock.  Type a b c			
		Dissipation Factor	R7: 0.1max	GCM15			
		Insulation Resistance	50Ω •F min.	GCM31 2.0 4.4 1.7 GCM32 2.0 4.4 2.6			
			100 Fig. 1 t:1.6mm	Pressurizing speed: 1. Omm/s Pressurize  Flexure: ≦2 (High Dielectric Type)			
			(GCM15:0.8mm)	+ 45 + 45 + Fig. 2			
19	Terminal Strength	Appearance Capacitance	No marking defects  Within specified tolerance	Solder the capacitor to the test jig (glass epoxy board) shown in Fig.3 using a eutectic solder. Then apply *18N force in parallel with the test jig for 60sec.			
		Change Dissipation Factor	R7: 0.1max	The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and gree of defects such as heat shock  *2N(GCM15)			
		Insulation Resistance	50Ω ·F min.	Type a b c GCM15 0.4 1.5 0.5 GCM18 1.0 3.0 1.2 GCM21 1.2 4.0 1.65 GCM31 2.2 5.0 2.0 GCM32 2.2 5.0 2.9  (in mm)			
			ラント* φ	T:1.6mm (GCM15:0.8mm)  Solder resist  Baked electrode or			
				Copper foil Fig. 3			
20	Beam Load Test		Destruction value should be exceed following one.  < Chip L dimension: 2.5mm max. >  Chip thickness > 0.5mm rank: 20N  Chip thickness ≤ 0.5mm rank: 8N  < Chip L dimension: 3.2mm max. >  Chip thickness < 1.25mm rank: 15N  Chip thickness ≥ 1.25mm rank: 54.5N	Place the capacitor in the beam load fixture as Fig 4. Apply a force.  < Chip Length: 2.5mm max. >			
				< Chip Length : 3.2mm min. >  Light Speed supplied the Stress Load : 0.5mm / sec.			



## ■AEC-Q200 Murata Standard Specification and Test Methods

No AEC-Q	200 Test Item	Specification.	AEC-Q200 Test Method
21 Capacitance Temperature Characteristics	Capacitance Change	R7 : Within ±15% (-55°C to +125°C)	The capacitance change should be measured after 5 min. at each specified temperature stage.  The ranges of capacitance change compared with the above 25°C value over the temperature ranges shown in the table should be within the specified ranges.  Initial measurement for high dielectric constant type.  Perform a heat treatment at 150+0/-10°C for one hour and then set for 24±2 hours at room temperature.  Perform the initial measurement.  Step Temperature.(°C)  1 25±2 2 -55±3(for \( \Delta \text{C to R7} \)) 3 25±2 4 125±3(for \( \Delta \text{C/R7} \)), 150±3(for 5G/L8),85±3(for other TC) 5 25±2

# 1.Tape Carrier Packaging(Packaging Code:D/E/W/F/L/J/K) 1.1 Minimum Quantity(pcs./reel)

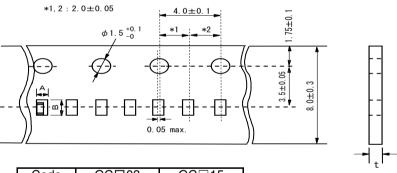
Туре		φ180mm reel			φ330mm reel		
		Paper Tape		Plastic Tape	Paper Tape	Plastic Tape	
		Code:D/E	Code:W	Code:L	Code:J/ F	Code:K	
GC□03		15000(W8P2)	30000(W8P1)		50000(W8P2)		
GC□15		10000(W8P2)	20000(W8P1)		50000(W8P2)		
GC□18		4000			10000		
	6	4000			10000		
GC□21	9	4000			10000		
	В			3000		10000	
	6	4000			10000		
GC□31	9	4000			10000		
ВСЦЗТ	M			3000		10000	
	С			2000		6000	
	9	4000			10000		
GC□32	М			3000		10000	
иош 32	Ν			2000		8000	
	R/D/E			1000		4000	
	М			1000		5000	
GC□43	N/R			1000		4000	
	E			500		2000	
GC□55	М			1000		5000	
ССЦ	N/R			1000		4000	

# 1.2 Dimensions of Tape (1)GC□03/15(W8P2 CODE:D/E/J/F)

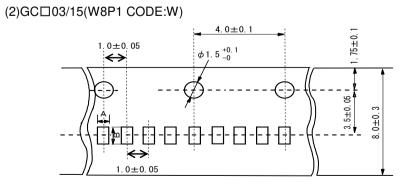
(in:mm)

(in:mm)

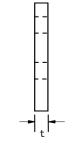
φ1



Code	GC□03	GC□15	
A *3	0.37	0.65	
B *3	0.67	1.15	*3 Nominal value
t	0.5 max.	0.8 max.	

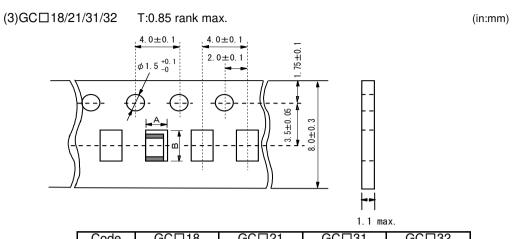


Code	GCI103	G
A *	0.37	0.65
B *	0.67	1.15
t	0.5 max.	0.8 max.

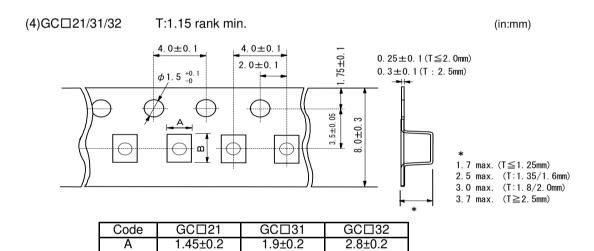


JEMCGP-01894A

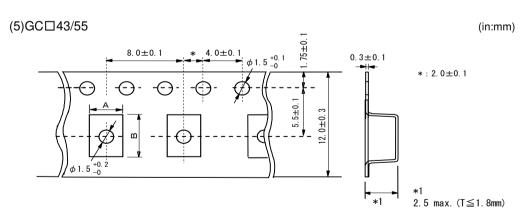
\* Nominal value



Code	GC□18	GC□21	GC□31	GC□32
Α	1.05±0.1	1.55±0.15	2.0±0.2	2.8±0.2
В	1.85±0.1	2.3±0.15	3.6±0.2	3.6±0.2



3.5±0.2



3.5±0.2

Code	GC□43	GC□55	
A *2	3.6	5.2	*2 Nominal value
B *2	4.9	6.1	]

В

2.25±0.2

状態 単位:

muRata

Package GC□ Type

Fig.1 Package Chips

(in:mm)

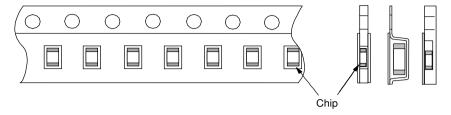


Fig.2 Dimensions of Reel

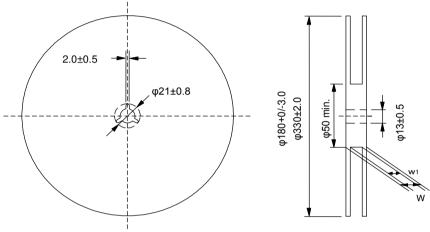
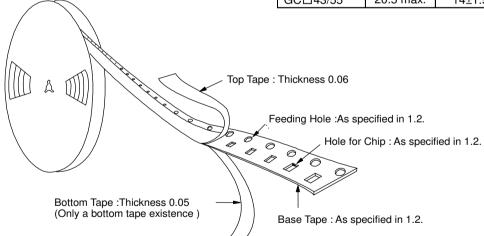


Fig.3 Taping Diagram

	W	<b>W</b> <sub>1</sub>
GC□32 max.	16.5 max.	10±1.5
GC□43/55	20.5 max.	14±1.5

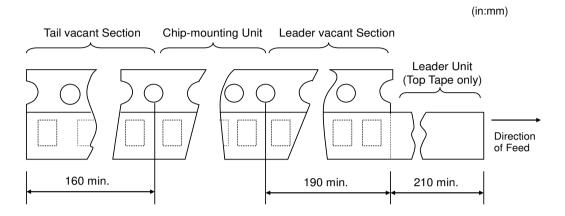


Fップ詰め状態

単位:

- 1.3 Tapes for capacitors are wound clockwise shown in Fig.3.

  (The sprocket holes are to the right as the tape is pulled toward the user.)
- 1.4 Part of the leader and part of the vacant section are attached as follows.



- 1.5 Accumulate pitch : 10 of sprocket holes pitch =  $40 \pm 0.3$ mm
- 1.6 Chip in the tape is enclosed by top tape and bottom tape as shown in Fig.1.
- 1.7 The top tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 1.8 There are no jointing for top tape and bottom tape.
- 1.9 There are no fuzz in the cavity.
- 1.10 Break down force of top tape : 5N min.
  Break down force of bottom tape : 5N min. (Only a bottom tape existence)
- 図 チップ 詰め状態 is made by resin and appeaser and dimens 単位s shown in Fig 2. There are possibly to change the material and dimension due to some impairment.
  - 1.12 Peeling off force: 0.1N to 0.6N\* in the direction as shown below.
    - \* GC□03:0.05N~0.5N

      165~180°

      Top tape

1.13 Label that show the customer parts number, our parts number, our company name, inspection number and quantity, will be put in outside of reel.

#### Limitation of use

Please contact our sales representatives or product engineers before using our products for the applications listed below which require of our products for other applications than specified in this product.

- ①Aircraft equipment ②Aerospace equipment ③Undersea equipment ④Power plant control equipment
- 5 Medical equipment 6 Transportation equipment (vehicles, trains, ships, etc.) 7 Traffic signal equipment
- (8) Disaster prevention / crime prevention equipment (9) Data-processing equipment
- (1) Application of similar complexity and/or requirements to the applications listed in the above

#### ■ Fail-safe

Be sure to provide an appropriate fail-safe function on your product to prevent a second damage that may be caused by the abnormal function or the failure of our product.

#### ■ Storage and Operation condition

- 1. The performance of chip monolithic ceramic capacitors may be affected by the storage conditions.
- 1-1. Store capacitors in the following conditions: Temperature of +5°C to +40°C and a Relative Humidity of 20% to 70%.
- (1) Sunlight, dust, rapid temperature changes, corrosive gas atmosphere or high temperature and humidity conditions during storage may affect the solderability and the packaging performance. Please use product within six months of receipt.
- (2) Please confirm solderability before using after six months. Store the capacitors without opening the original bag. Even if the storage period is short, do not exceed the specified atmospheric conditions.
- 1-2. Corrosive gas can react with the termination (external) electrodes or lead wires of capacitors, and result in poor solderability. Do not store the capacitors in an atmosphere consisting of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.).
- 1-3. Due to moisture condensation caused by rapid humidity changes, or the photochemical change caused by direct sunlight on the terminal electrodes and/or the resin/epoxy coatings, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or in high huimidity conditions

#### ■ Rating

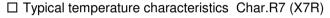
#### **1.Temperature Dependent Characteristics**

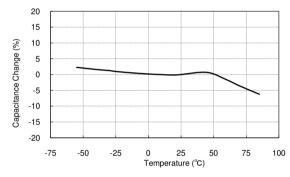
- 1. The electrical characteristics of the capacitor can change with temperature.
- 1-1. For capacitors having larger temperature dependency, the capacitance may change with temperature changes. The following actions are recommended in order to insure suitable capacitance values.
  - (1) Select a suitable capacitance for the operating temperature range.
  - (2) The capacitance may change within the rated temperature.
    - When you use a high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance.

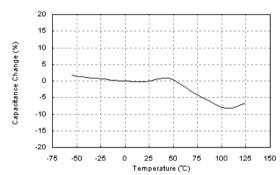
Example: a time constant circuit., please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics.

And check capacitors using your actual appliances at the intended environment and operating conditions.

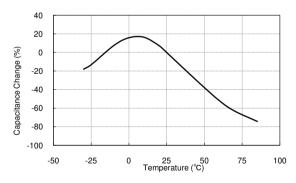
☐ Typical temperature characteristics Char.R6 (X5R)







☐ Typical temperature characteristics Char.F5 (Y5V)



#### 2.Measurement of Capacitance

- 1. Measure capacitance with the voltage and the frequency specified in the product specifications.
- 1-1. The output voltage of the measuring equipment may decrease when capacitance is high occasionally. Please confirm whether a prescribed measured voltage is impressed to the capacitor.
- 1-2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

#### 3. Applied Voltage

- 1. Do not apply a voltage to the capacitor that exceeds the rated voltage as called-out in the specifications.
- 1-1. Applied voltage between the terminals of a capacitor shall be less than or equal to the rated voltage.
- (1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated DC voltage. When AC voltage or pulse voltage is applied, the peak-to-peak voltage shall not exceed the rated DC voltage.
- (2) Abnormal voltages (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated DC voltage.

(E: Maximum possible applied voltage.)

#### 1-2. Influence of overvoltage

Overvoltage that is applied to the capacitor may result in an electrical short circuit caused by the breakdown of the internal dielectric layers .

The time duration until breakdown depends on the applied voltage and the ambient temperature.

#### 4. Applied Voltage and Self-heating Temperature

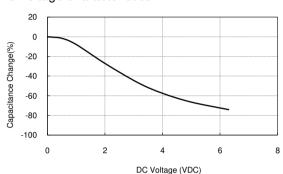
- 1. When the capacitor is used in a high-frequency voltage, pulse voltage, application, be sure to take into account self-heating may be caused by resistant factors of the capacitor.
- 1-1. The load should be contained to the level such that when measuring at atomospheric temperature of 25°C, the product's self-heating remains below 20°C and surface temperature of the capacitor in the actual circuit remains wiyhin the maximum operating temperature.

#### 5. DC Voltage and AC Voltage Characteristic

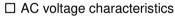
- 1. The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.
- 1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage. (See figure) Please confirm the following in order to secure the capacitance.
- (1) Whether the capacitance change caused by the applied voltage is within the range allowed or not.

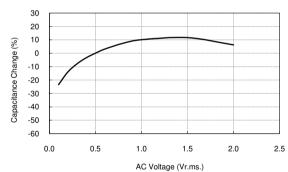
□ DC voltage characteristics

(2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases. Even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is in a circuit that needs a tight (narrow) capacitance tolerance. Example: a time constant circuit., please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics. And check capacitors using your actual appliances at the intended environment and operating conditions.



2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

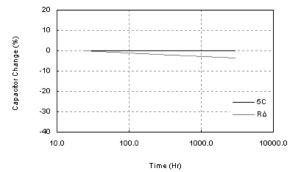




#### 6. Capacitance Aging

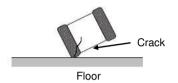
- 1. The high dielectric constant type capacitors have the characteristic in which the capacitance value decreases with the passage of time.
  - When you use a high dielectric constant type capacitors in a circuit that needs a tight (narrow) capacitance tolerance. Example: a time constant circuit., please carefully consider the characteristics of these capacitors, such as their aging, voltage, and temperature characteristics.

And check capacitors using your actual appliances at the intended environment and operating conditions.

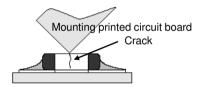


#### 7. Vibration and Shock

- 1. The capacitors mechanical actress (vibration and shock) shall be specified for the use environment. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance. Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
- 2. Mechanical shock due to falling may cause damage or a crack in the dielectric material of the capacitor. Do not use a fallen capacitor because the quality and reliability may be deteriorated.



3. When printed circuit boards are piled up or handled, the corners of another printed circuit board should not be allowed to hit the capacitor in order to avoid a crack or other damage to the capacitor.



#### ■ Soldering and Mounting

#### 1.Mounting Position

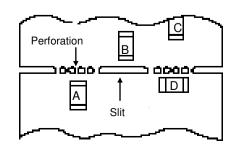
- 1. Confirm the best mounting position and direction that minimizes the stress imposed on the capacitor during flexing or bending the printed circuit board.
- 1-1. Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.

#### [Component Direction]



Locate chip horizontal to the direction in which stress acts

[Chip Mounting Close to Board Separation Point]



Chip arrangement Worst A-C-(B~D) Best

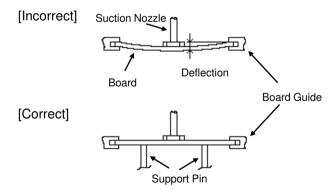
#### 2.Information before mounting

- 1. Do Not re-use capacitors that were removed from the equipment.
- 2. Confirm capacitance characteristics under actual applied voltage.
- 3. Confirm the mechanical stress under actual process and equipment use.
- 4. Confirm the rated capacitance, rated voltage and other electrical characteristics before assembly.
- 5. Prior to use, confirm the Solderability for the capacitors that were in long-term storage.
- 6. Prior to measuring capacitance, carry out a heat treatment for capacitors that were in long-term storage.
- 7. The use of Sn-Zn based solder will deteriorate the reliability of the MLCC.

  Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.

#### 3. Maintenance of the Mounting (pick and place) Machine

- 1. Make sure that the following excessive forces are not applied to the capacitors.
- 1-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to a minimum to prevent them from any bending damage or cracking. Please take into account the following precautions and recommendations for use in your process.
- (1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.
- (2) Adjust the nozzle pressure within a static load of 1N to 3N during mounting.



2.Dirt particles and dust accumulated between the suction nozzle and the cylinder inner wall prevent the nozzle from moving smoothly. This imposes greater force upon the chip during mounting, causing cracked chips. Also the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked and replaced periodically.





#### 4-1.Reflow Soldering

- When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB board. Preheating conditions are shown in table 1. It is required to keep the temperature differential between the solder and the components surface (ΔT) as small as possible.
- Solderability of Tin plating termination chips might be deteriorated when a low temperature soldering profile where the peak solder temperature is below the melting point of Tin is used. Please confirm the Solderability of Tin plated termination chips before use.
- When components are immersed in solvent after mounting be sure to maintain the temperature difference (ΔT) between the component and the solvent within the range shown in the table 1.

Table 1

Table 1			
Part Number	Temperature Differential		
GC□03/15/18/21/31	ΔΤ≦190°C		
GC□32	ΔΤ≦130°C		

#### **Recommended Conditions**

	Pb-Sn	Lead Free Solder	
	Infrared Reflow Vapor Reflow		
Peak Temperature	230~250°C	230~240°C	240~260°C
Atmosphere	Air	Air	Air or N2

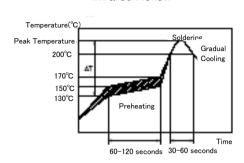
Pb-Sn Solder: Sn-37Pb

Lead Free Solder: Sn-3.0Ag-0.5Cu

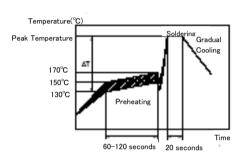
- 4. Optimum Solder Amount for Reflow Soldering
- 4-1. Overly thick application of solder paste results in a excessive solder fillet height. This makes the chip more susceptible to mechanical and thermal stress on the board and may cause the chips to crack.
- 4-2. Too little solder paste results in a lack of adhesive strength on the outer electrode, which may result in chips breaking loose from the PCB.

#### [Standard Conditions for Reflow Soldering]

#### Infrared Reflow



Vapor Reflow



#### [Allowable Soldering Temperature and Time]



In case of repeated soldering, the accumulated soldering time must be within the range shown above.



\* GC □ 03: 1/3 of Chip Thickness min.

in section

4-3. Make sure the solder has been applied smoothly to the end surface to a height of 0.2mm\* min.

Inverting the PCB

JEMCGC-2702N

#### 4-2.Flow Soldering

- 1. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage in the components, preheating should be required for both of the components and the PCB board. Preheating conditions are shown in table 2. It is required to keep temperature differential between the solder and the components surface (ΔT) as small as possible.
- Excessively long soldering time or high soldering temperature can result in leaching of the outer electrodes, causing poor adhesion or a reduction in capacitance value due to loss of contact between electrodes and end termination.
- 3. When components are immersed in solvent after mounting, be sure to maintain the temperature difference ( $\Delta T$ ) between the component and solvent within the range shown in the table 2.
- 4. Do not apply flow soldering to chips not listed in Table 2.

Table 2

. 4.5.6 =			
Part Number	Temperature Differential		
GC□18/21/31	ΔΤ≦150°C		

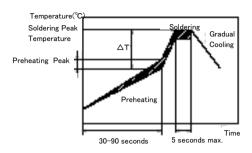
#### **Recommended Conditions**

	Pb-Sn Solder	Lead Free Solder
Preheating Peak Temperature	90~110°C	100∼120°C
Soldering Peak Temperature	240~250°C	250~260°C
Atmosphere	Air	N <sub>2</sub>

Pb-Sn Solder: Sn-37Pb Lead Free Solder: Sn-3.0Ag-0.5Cu

- Optimum Solder Amount for Flow Soldering
- 5-1. The top of the solder fillet should be lower than the thickness of components. If the solder amount is excessive, the risk of cracking is higher during board bending or any other stressful condition.

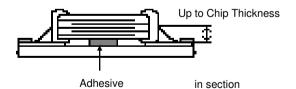
#### [Standard Conditions for Flow Soldering]



[Allowable Soldering Temperature and Time]



In case of repeated soldering, the accumulated soldering time must be within the range shown above.



#### 4-3. Correction with a Soldering Iron

- 1. When sudden heat is applied to the components when using a soldering iron, the mechanical strength of the components will decrease because the extreme temperature change can cause deformations inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB board. Preheating conditions, (The "Temperature of the Soldering Iron tip", "Preheating Temperature", "Temperature Differential" between the iron tip and the components and the PCB), should be within the conditions of table 3. It is required to keep the temperature differential between the soldering Iron and the component surfaces (ΔT) as small as possible.
- 2. After soldering, do not allow the component/PCB to rapidly cool down.
- 3. The operating time for the re-working should be as short as possible. When re-working time is too long, it may cause solder leaching, and that will cause a reduction in the adhesive strength of the terminations.

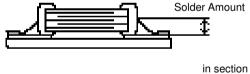
Table 3

Part Number	Temperature of Soldering Iron tip	Preheating Temperature	Temperature Differential (ΔT)	Atmosphere
GC 03/15/18/21/31	350°C max.	150°C min.	ΔT≦190°C	Air
GC□32	280°C max.	150°C min.	ΔT≦130°C	Air

<sup>\*</sup>Applicable for both Pb-Sn and Lead Free Solder Pb-Sn Solder: Sn-37Pb

Lead Free Solder: Sn-3.0Ag-0.5Cu

- 4. Optimum Solder amount when re-working with a Soldering Iron
- 4-1. In case of sizes smaller than 0603, (GC□03/15/18), the top of the solder fillet should be lower than 2/3's of the thickness of the component or 0.5mm whichever is smaller. In case of 0805 and larger sizes, (GC□21/31/32), the top of the solder fillet should be lower than 2/3's of the thickness of the component. If the solder amount is excessive, the risk of cracking is higher during board bending or under any other stressful condition.



- III Section
- 4-2. A Soldering iron with a tip of ø3mm or smaller should be used. It is also necessary to keep the soldering iron from touching the components during the re-work.
- 4-3. Solder wire with Ø0.5mm or smaller is required for soldering.

#### **4-4.Leaded Component Insertion**

 If the PCB is flexed when leaded components (such as transformers and ICs) are being mounted, chips may crack and solder joints may break.
 Before mounting leaded components, support the PCB using backup pins or special jigs to prevent warping.

#### 5.Washing

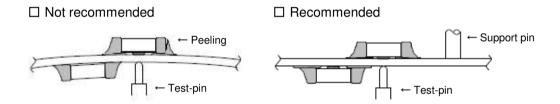
Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Take note not to vibrate PCBs.

#### **6.Electrical Test on Printed Circuit Board**

- 1. Confirm position of the support pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.
- 1-1. Avoid bending printed circuit board by the pressure of a test pin, etc.

  The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints.

  Provide support pins on the back side of the PCB to prevent warping or flexing.
- 1-2. Avoid vibration of the board by shock when a test pin contacts a printed circuit board.



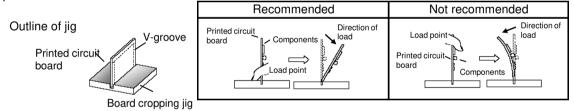
#### 7.Printed Circuit Board Cropping

- 1. After mounting a capacitor on a printed circuit board, do not apply any stress to the capacitor that is caused by bending or twisting the board.
- 1-1. In cropping the board, the stress as shown right may cause the capacitor to crack. Try not to apply this type of stress to a capacitor.



- 2. Check of the cropping method for the printed circuit board in advance.
- 2-1. Printed circuit board cropping shall be carried out by using a jig or an apparatus to prevent the mechanical stress which can occur to the board.
  - (1) Example of a suitable jig

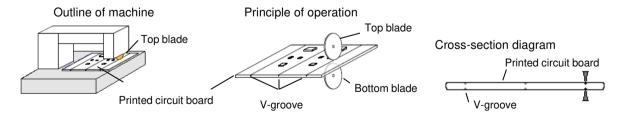
Recommended example: the board should be pushed as close to the near the cropping jig as possible and from the back side of board in order to minimize the compressive stress applied to capacitor. Not recommended example\* when the board is pushed at a point far from the cropping jig and from the front side of board as below, the capacitor may form a crack caused by the tensile stress applied to capacitor.

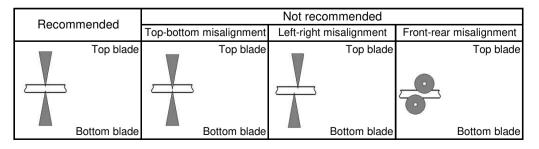


(2) Example of a suitable machine

An outline of a printed circuit board cropping machine is shown as follows. Along the lines with the V-grooves on printed circuit board, the top and bottom blades are aligned to one another when cropping the board.

The misalignment of the position between top and bottom blades may cause the capacitor to crack.





#### ■ Others

#### 1. Under Operation of Equipment

- 1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of a electric shock.
- 1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit). Do not expose a capacitor to a conductive liquid, inducing any acid or alkali solutions.
- 1-3. Confirm the environment in which the equipment will operation is under the specified conditions. Do not use the equipment under the following environment.
  - (1) Being spattered with water or oil.
  - (2) Being exposed to direct sunlight.
  - (3) Being exposed to Ozone, ultraviolet rays or radiation.
  - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
  - (5) Any vibrations or mechanical shocks exceeding the specified limits.
  - (6) Moisture condensing environments.
- 1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

#### 2. Others

#### 2-1. In an Emergency

- (1) If the equipment should generate smoke, fire or smell, immediately turn off or unplug the equipment. If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
- (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitors high temperature.

#### 2-2. Disposal of waste

When capacitors are disposed, they must be burned or buried by the industrial waste vender with the appropriate licenses.

#### 2-3. Circuit Design

GC□ Series capacitors in this specification are not safety recognized products.

#### 2-4. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used. The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions.

Select optimum conditions for operation as they determine the reliability of the product after assembly. The data herein are given in typical values, not guaranteed ratings.

#### ■ Rating

#### 1. Operating Temperature

- 1. The operating temperature limit depends on the capacitor.
- 1-1.Do not apply temperatures exceeding the upper operating temperature.
  - It is necessary to select a capacitor with a suitable rated temperature which will cover the operating temperature range.
  - Also it is necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
- 1-2. Consider the self-heating of the capacitor
  - The surface temperature of the capacitor shall be the upper operating temperature or less when including the self-heating factors.

#### 2. Atmosphere surroundings (gaseous and liquid)

- 1. Restriction on the operating environment of capacitors.
- 1-1. The capacitor, when used in the above, unsuitable, operating environments may deteriorate due to the corrosion of the terminations and the penetration of moisture into the capacitor.
- 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
- 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

#### 3. Piezo-electric Phenomenon

- 1. When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated.
  - Moreover, when the mechanical vibration or shock is added to capacitor, noise may occur.

### ■ Soldering and Mounting

#### 1.PCB Design

- 1. Notice for Pattern Forms
- 1-1. Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate.

They are also more sensitive to mechanical and thermal stresses than leaded components. Excess solder fillet height can multiply these stresses and cause chip cracking. When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.

1-2. It is possible for the chip to crack by the expansion and shrinkage of a metal board.

Please contact us if you want to use our ceramic capacitors on a metal board such as Aluminum.

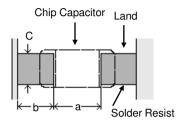
#### Pattern Forms

Pattern Forms		
	Prohibited	Correct
Placing Close to Chassis	Chassis Solder (ground) Electrode Pattern	Solder Resist
Placing of Chip Components and Leaded Components	Lead Wire	Solder Resist
Placing of Leaded Components after Chip Component	Soldering Iron Lead Wire	Solder Resist
Lateral Mounting		Solder Resist

#### 2. Land Dimensions

2-1. Chip capacitor can be cracked due to the stress of PCB bending / etc if the land area is larger than needed and has an excess amount of solder.

Please refer to the land dimensions in table 1 for flow soldering, table 2 for reflow soldering.



Please confirm the suitable land dimension by evaluating of the actual SET / PCB.

Table 1 Flow Soldering Method

Table 11 low Soldering Method					
Dimensions Part Number	Chip (L×W)	а	b	С	
GC□18	1.6×0.8	0.6~1.0	0.8~0.9	0.6~0.8	
GC□21	2.0×1.25	1.0~1.2	0.9~1.0	0.8~1.1	
GC□31	3.2×1.6	2.2~2.6	1.0~1.1	1.0~1.4	
				(' )	

(in mm)

Table 2 Reflow Soldering Method

Dimensions Part Number	Chip (L×W)	а	b	С
GC□03	0.6×0.3	0.2~0.3	0.2~0.35	0.2~0.4
GC□15	1.0×0.5	0.3~0.5	0.35~0.45	0.4~0.6
GC□18	1.6×0.8	0.6~0.8	0.6~0.7	0.6~0.8
GC□21	2.0×1.25	1.0~1.2	0.6~0.7	0.8~1.1
GC□31	3.2×1.6	2.2~2.4	0.8~0.9	1.0~1.4
GC□32	3.2×2.5	2.0~2.4	1.0~1.2	1.8~2.3

(in mm)